

# Multispectral Imaging for Materials Analysis

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# Measurement paradigms – materials analysis:

## 1) Serial:

- throughput (significantly) enhanced by automation/scanning.
- e.g., mass spec, chromatography screening.

## 2) Parallel:

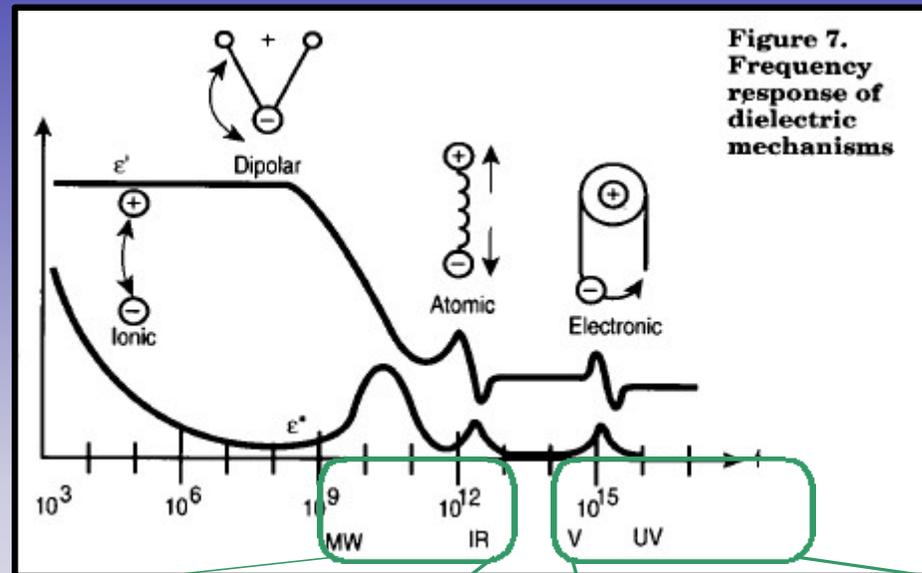
- 2D array-based detection “views” entire library.
- e.g., IR thermography, hyperspectral imaging, anode-array REMPI.

## • Multitasking:

- data on two or more distinct system properties using a single integrated measurement platform.
- serial or parallel based techniques.
- e.g., CCD-based detection of selective oxidation of naphthalene:  
LIF – reaction product; NIR emission – thermography  
(*H. Su and E.S. Yeung; JACS* **122**, 7422, '00; *H. Su, Y. Hou, R.S. Houk, G.L. Schrader and E.S. Yeung, Anal. Chem.* **73**, 4434, '01)

# Multitasking Probe: motivation and systems.

- Single instrument platform: materials performance and properties.
- Dielectric thin films.



## Targeted performance frequency range:

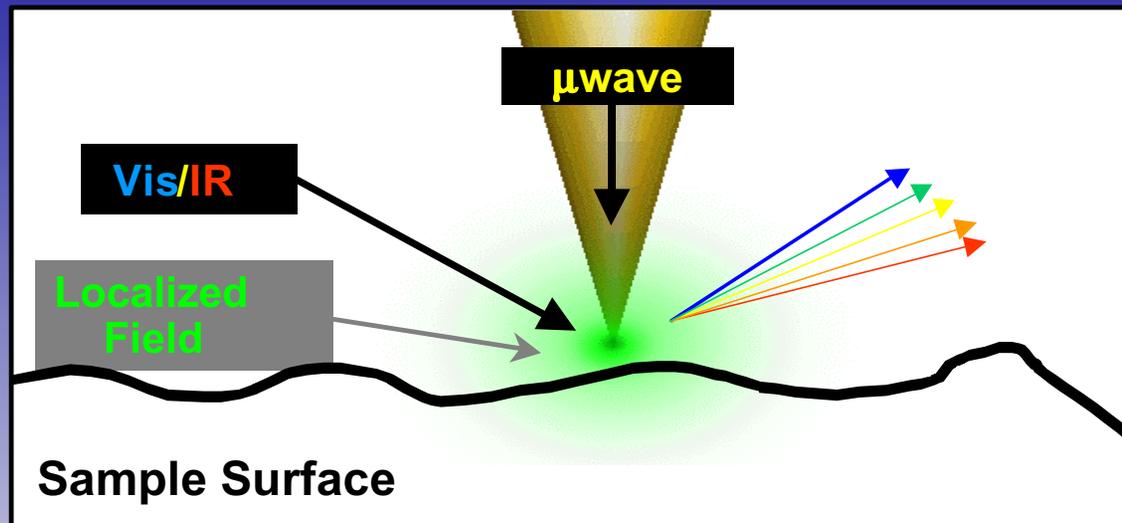
- High- $\epsilon$  mat'l: DRAM, capacitors, ...
- Low- $\epsilon$  mat'l: next-generation Si, ...

## Probes of key materials properties:

- Structural: phase, stress, ...
- Chemical: composition, impurities ...

# Integrated Multitasking/Multispectral Probe:

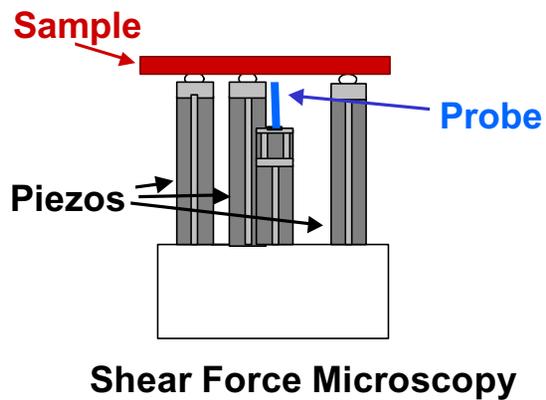
⇒ evanescent probe in the near-field; sharpened metal tip  $\approx 10$  nm from surface



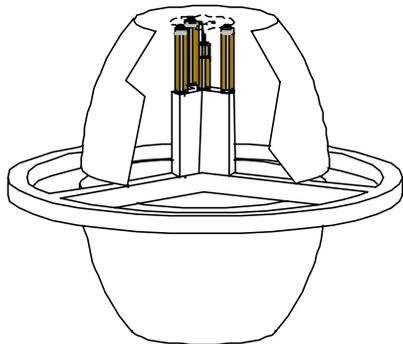
- 1) **Part of  $\mu$ wave cavity: materials performance by NS $\mu$ M (Near-field Scanning Microwave Microscopy)**
  - dielectric loss spectroscopy.
  - probes local complex dielectric constant.
- 2) **External Vis/IR illumination: materials properties by aNSOM (apertureless Near-field Scanning Optical Microscopy)**
  - local field enhanced IR absorption/Raman scattering.
  - probes local chemical functionality/structure.

# Instrumentation: fully-integrated system (not yet realized !)

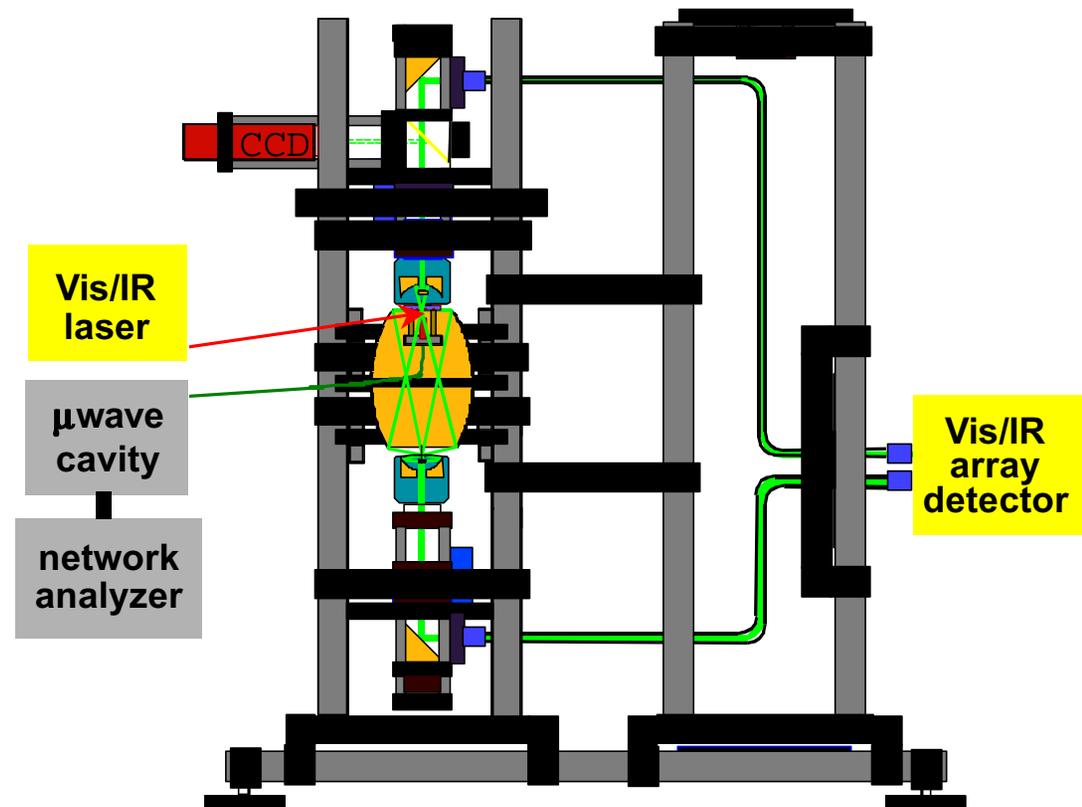
## Probe Positioning/Scanning:



## Gold-coated ellipsoidal cavity for light collection:



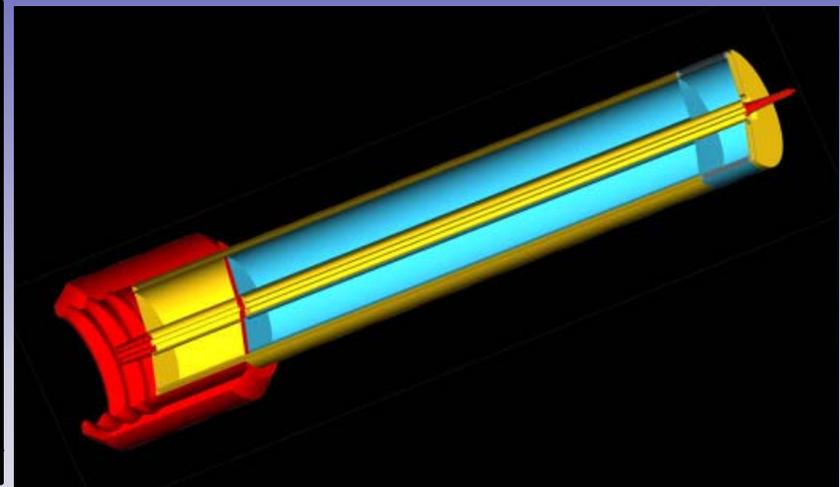
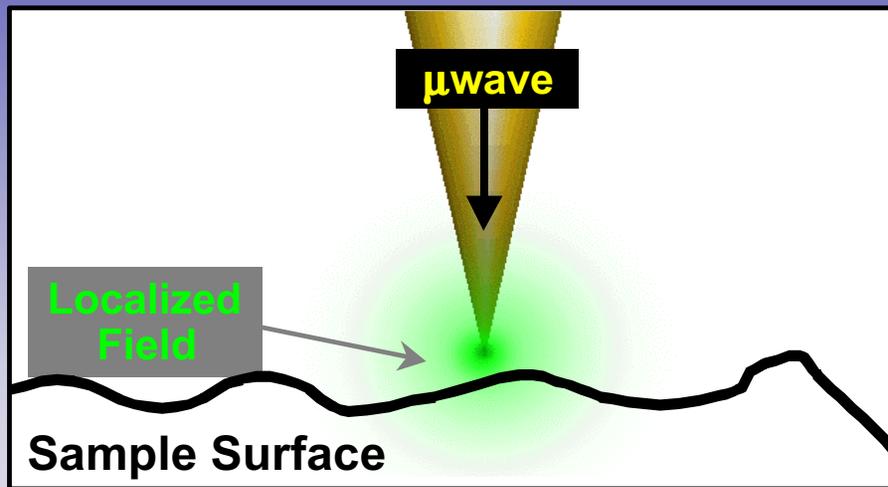
## Multitasking aNSOM/NS $\mu$ M:



# 1) NS $\mu$ M – Near-field Scanning Microwave Microscopy:

## Developed in the mid '90s:

- X.-D. Xiang – LBNL; S.M. Anlage, F.C. Wellstood – U. Maryland
- Used by Xiang *et al.* for HTS/HTE of advanced oxide materials:  
APL **72**, 2185 ('98); Mat.Sci. Eng. B. – Sol. **56**, 246 ('98); Biotech. Bioeng. **61**, 227 ('99).

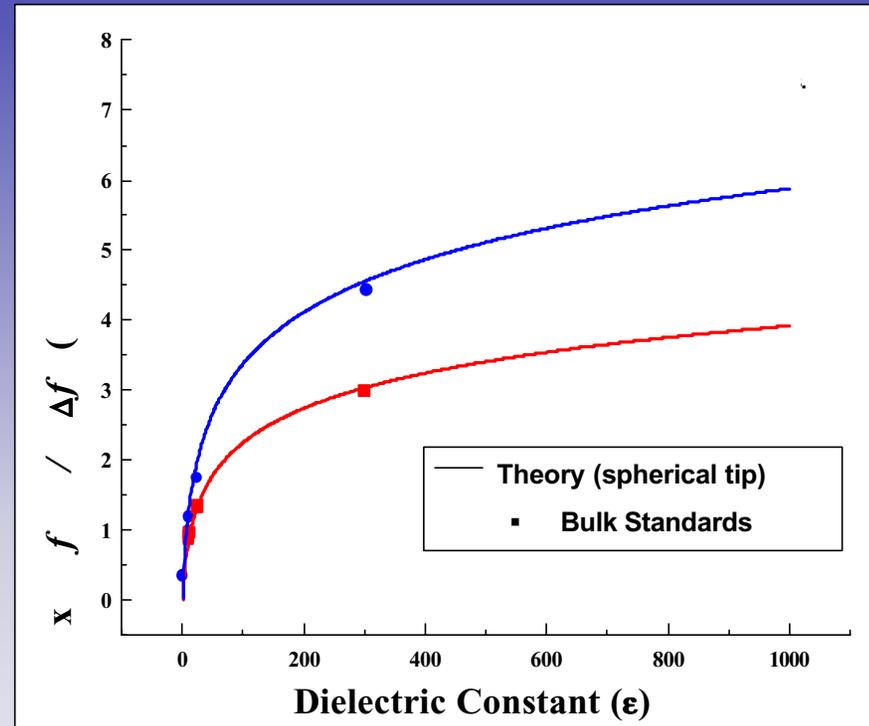
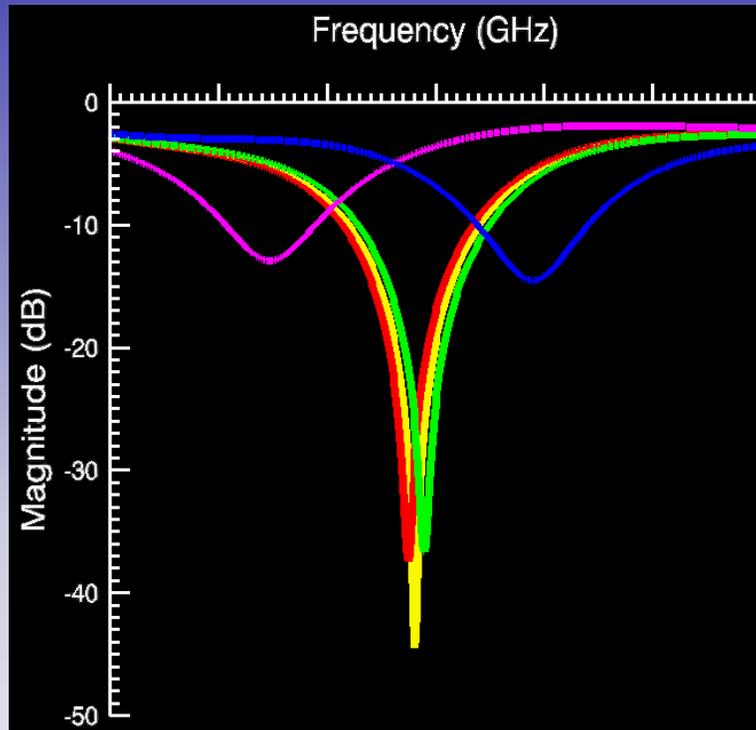


## Advantages:

- 1) Non-contact
- 2) Sample geometry independent
- 3) Thin film samples  
⇒ Suitable for HTS/HTE.

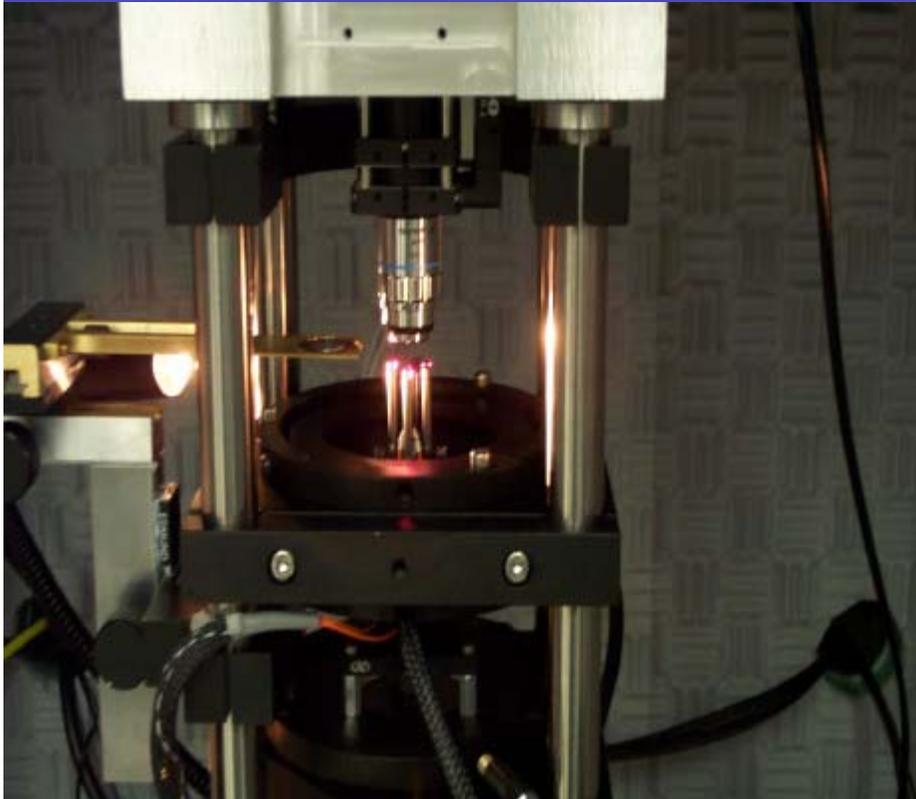
# Dielectric Imaging: NS $\mu$ M

- By measuring the frequency shift of the microscope's resonant cavity, a dielectric response can be determined.



Spatial resolution  $\Rightarrow$  probe shape/radius; height from sample surface.  
 $\epsilon$  precision  $\Rightarrow$   $\Delta f/f$  and cavity Q. 1

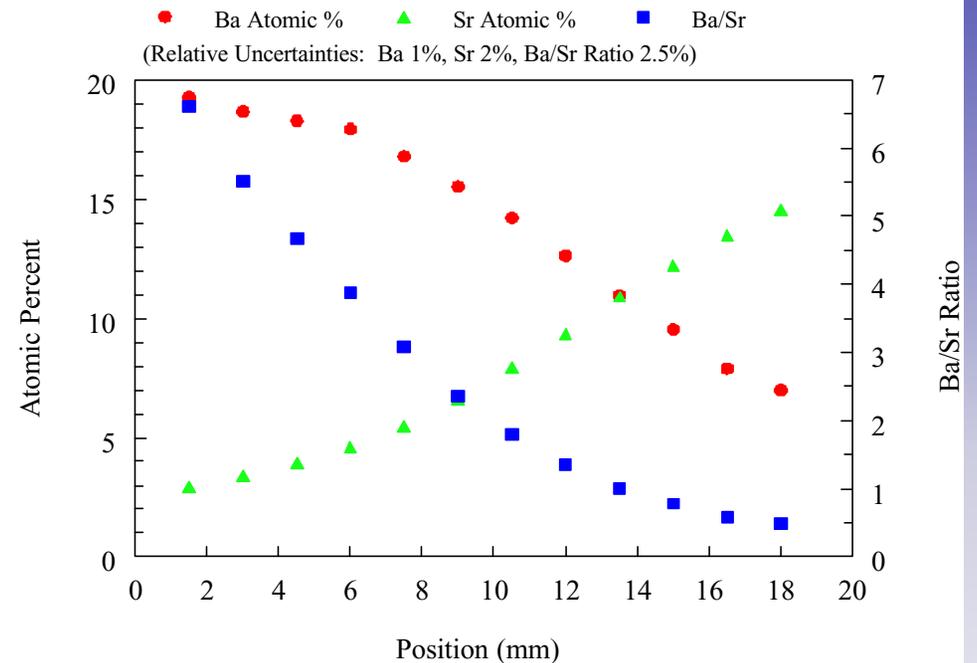
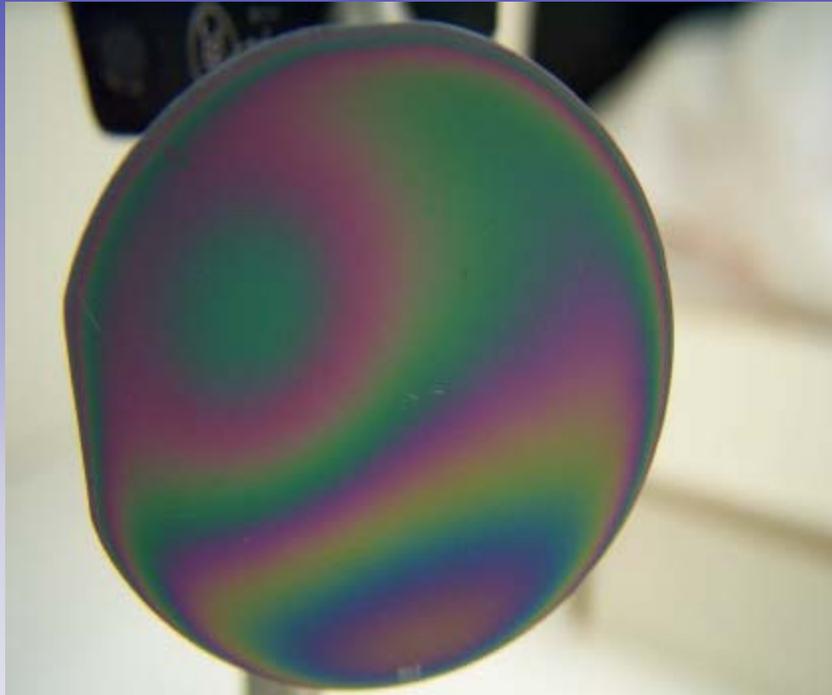
## Near-field Scanning Microwave Microscope:



- Diffraction-limitless resolution.  
*(~ 100 nm in xyz)*
- Shear-force feedback height regulation.  
*(typically 10-50 nm)*
- Broadband Measurement.  
*( 45 MHz to 20 GHz)*
- Network analyzer:  $\Delta f/f \approx 10^{-5}$  to  $10^{-6}$ .  
*( $\epsilon$  to about 1-5 %)*

## Demonstration of NS $\mu$ M:

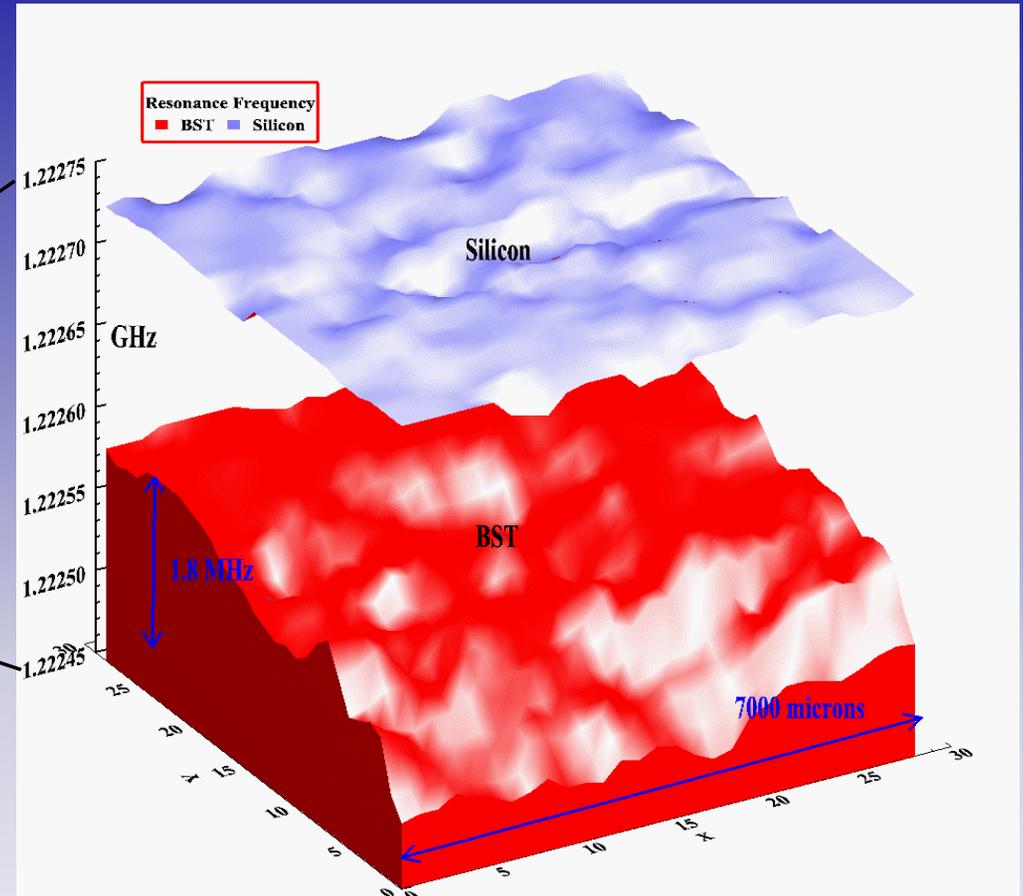
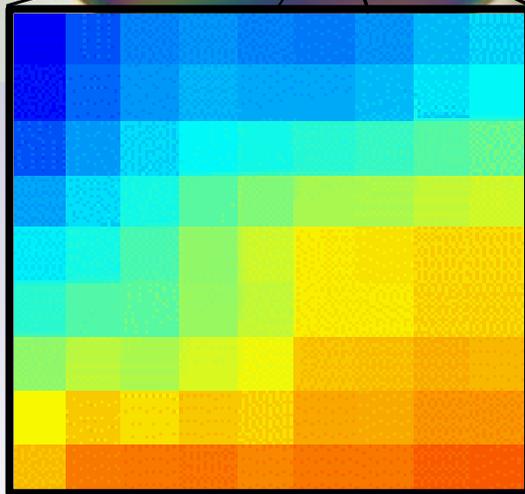
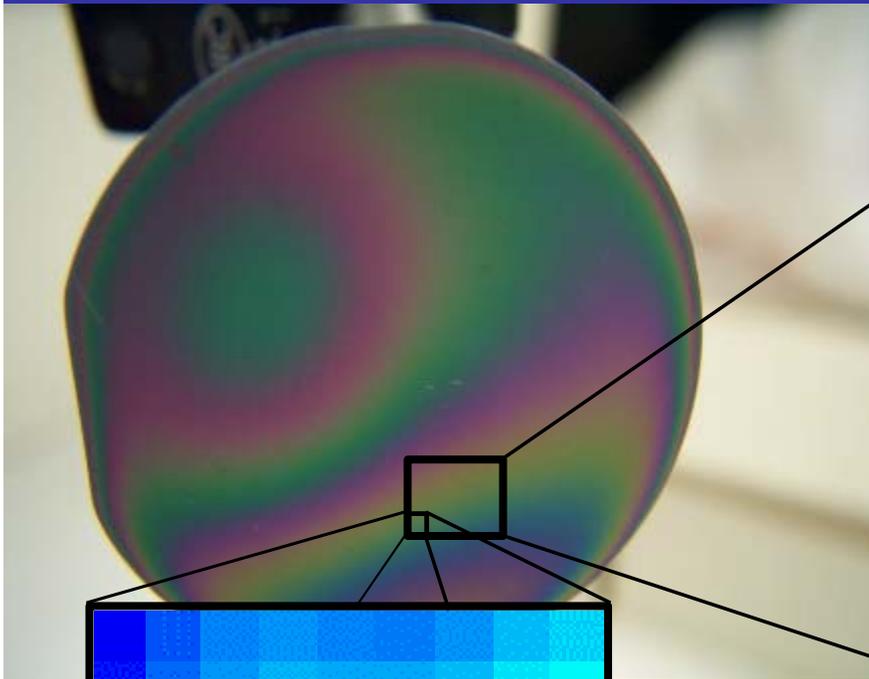
- continuous compositional gradient Barium Strontium Titanate (BST) film.
- prepared by dual-beam pulsed laser deposition.



- Film thickness variation is evident.
- Quantitative analysis by spectrometric reflectometry.

- Compositional gradient quantified by wavelength-dispersive electron probe microanalysis.

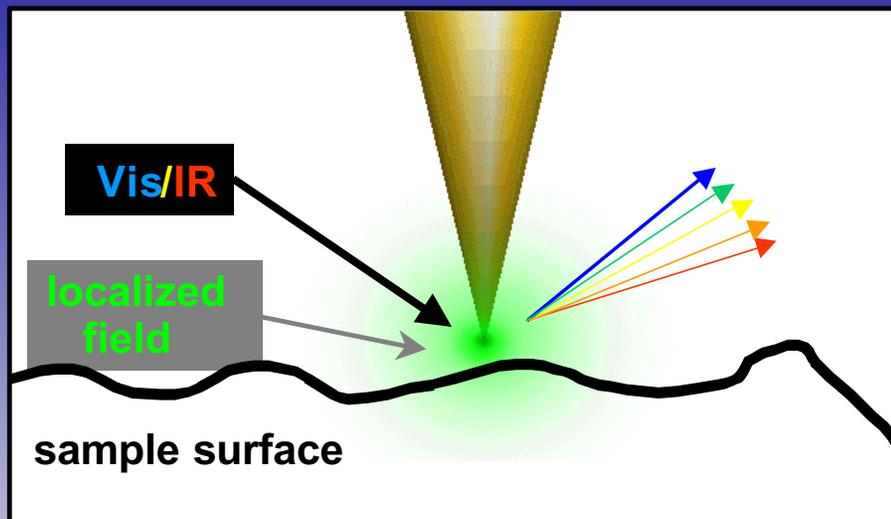
# Dielectric Response Mapping using NS $\mu$ M:



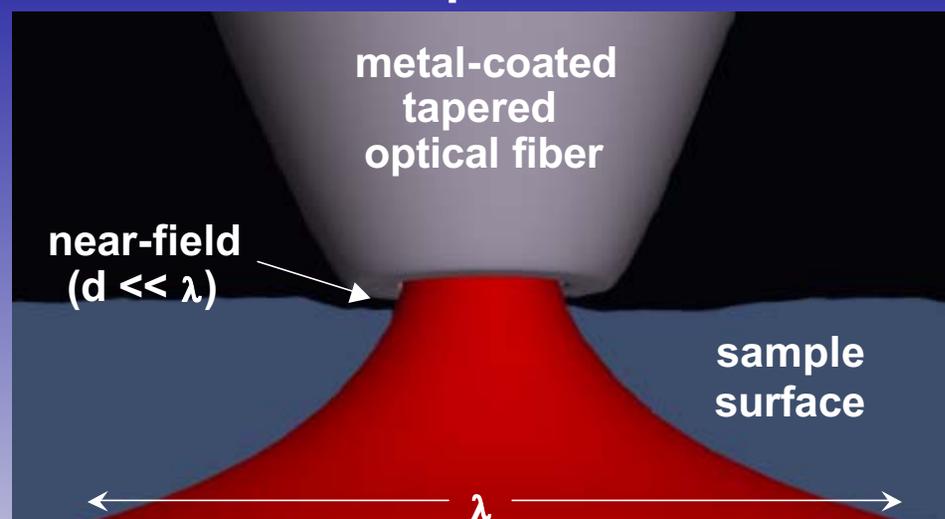
► Dielectric response dominated is by film thickness variations. ◀

## 2) aNSOM - apertureless Near-field Scanning Optical Microscopy

aNSOM



Fiber-coupled NSOM



Wickramasinghe, IBM '94; Kawata, Osaka U. '94

Pohl, IBM '83; Lewis, Cornell U., '83

### Similarities:

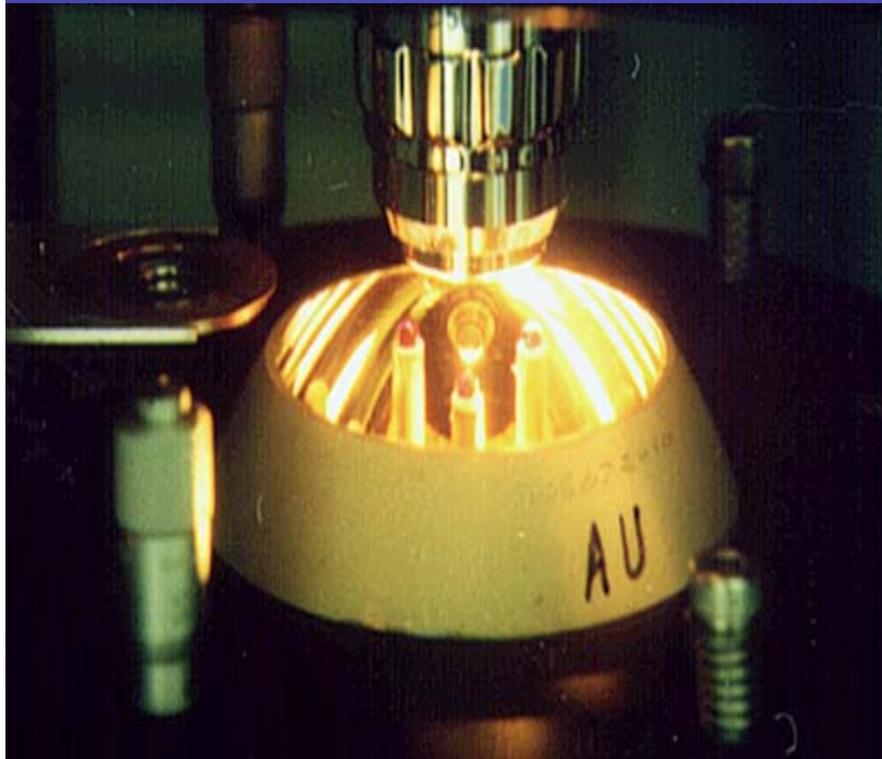
- near field scanned probe
- subwavelength resolution
- chemical imaging/spectroscopy

### Differences:

- radiation coupling
- accessible wavelengths
- resolution: 1-2 nm vs  $\approx 50$  nm

**NIST; chemical-imaging using Raman/IR fiber-coupled NSOM:**  
*results illustrate expectations for aNSOM in multitasking application*

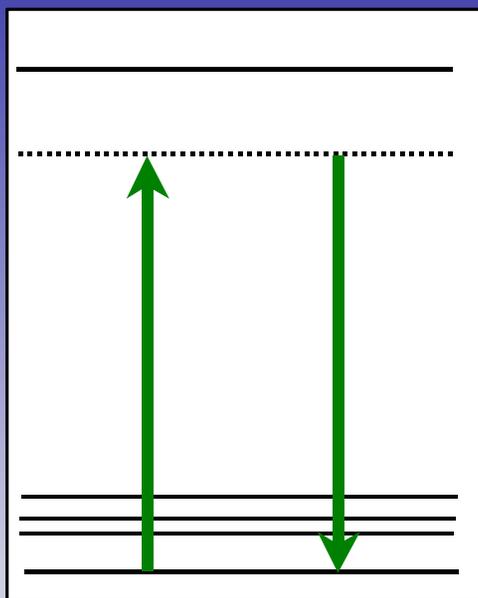
## Fiber-coupled NSOM:



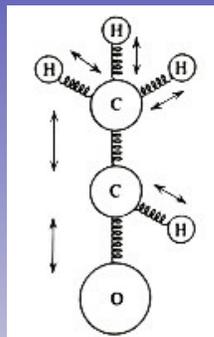
- Diffraction-limitless resolution.  
*(~ 100 nm lateral)*
- Shear-force feedback height regulation.  
*(typically 10-50 nm)*
- NUV to NIR ( $0.3 - 1 \mu\text{m}$ ; *Raman*)  
IR ( $2.5 - 10 \mu\text{m}$ ; *IR absorption*)
- Hyperspectral imaging.  
*(spectrum at each spatial pixel)*

# Raman Scattering Spectroscopy/NSOM:

## Rayleigh Scattering (Elastic Process)

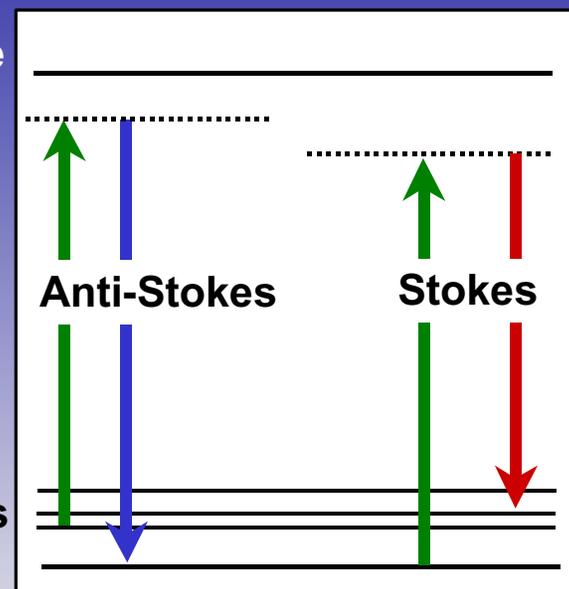


## Molecular Excited State (Virtual Excited State)



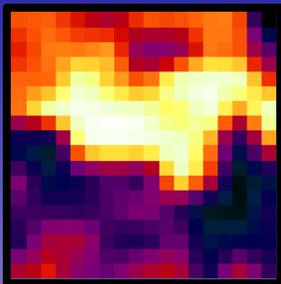
## Vibrational Energy Levels Molecular Ground State

## Raman Scattering (Inelastic Process)

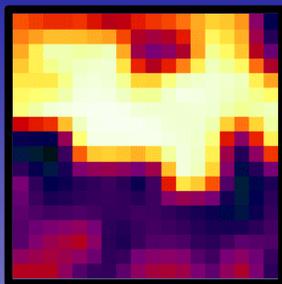


- {
  - Highly specific chemical information/species and structure.
  - Visible lasers/"standard" fiber optics.
- {
  - Inefficient process: only **one** in  $10^{13}$  photons Raman scatter.
  - NSOM probes have low throughput:  $\sim 10^{-5} - 10^{-6}$ .

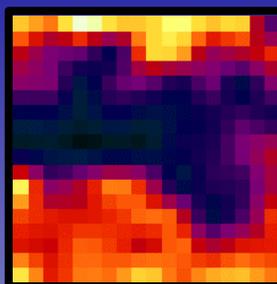
Rayleigh  
514 nm



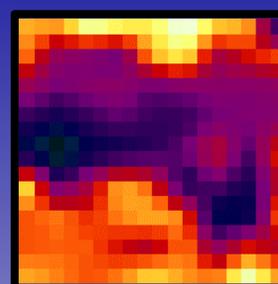
Glass ( $\text{SiO}_x$ )  
775  $\text{cm}^{-1}$



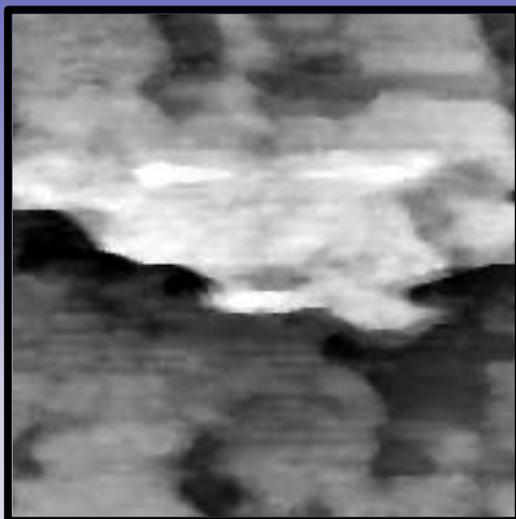
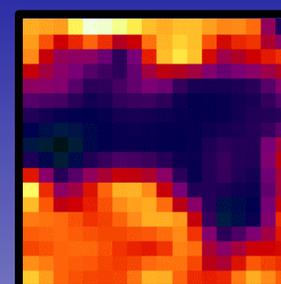
Rhodamine-B  
1350  $\text{cm}^{-1}$



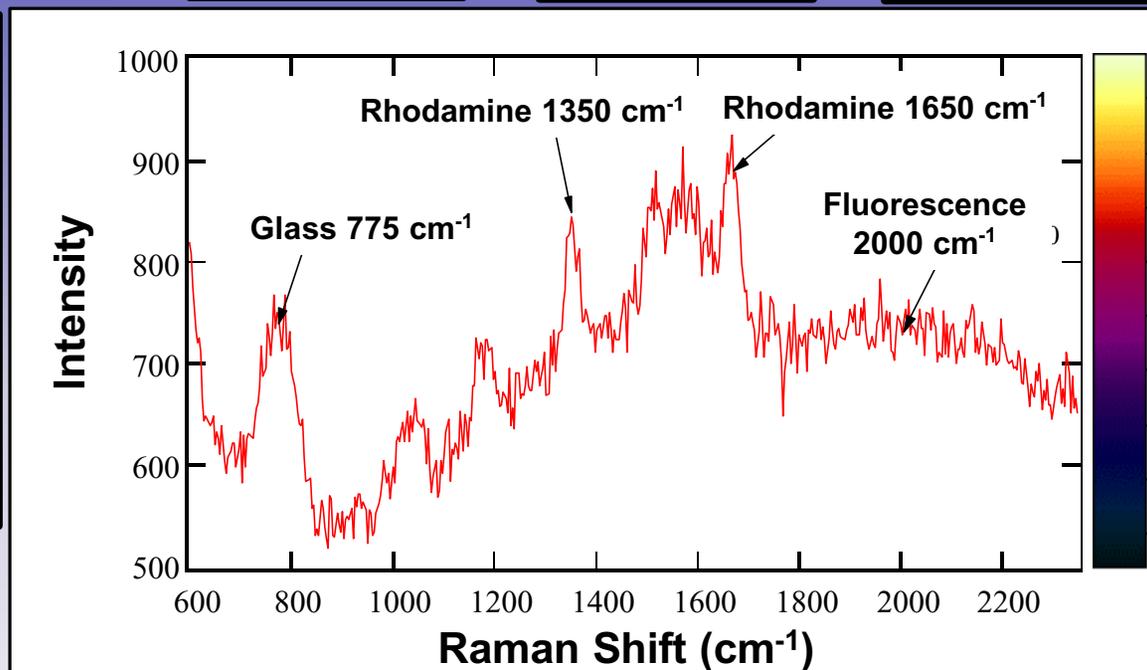
Rhodamine-B  
1650  $\text{cm}^{-1}$



Fluorescence  
2000  $\text{cm}^{-1}$



Shear-force Image  
3  $\mu\text{m}$  x 3  $\mu\text{m}$



- 50 nm Ag film on glass, 0.7  $\mu\text{M}$  Rhodamine-B sol.

## Summary:

### **Program Goal - multitasking scanned probe for HTE/HTS:**

- *simultaneously* obtain data for materials performance (dielectric constant) *and* materials properties (chemical composition/structure).
- targeting high-density ( $\mu\text{m}$  length scale) discrete samples and/or continuous compositional gradient materials libraries.

### **Integrated NS $\mu$ M/aNSOM platform:**

- not yet fully realized.
- have demonstrated independently the workability of Raman/IR fiber-coupled NSOM and NS $\mu$ M on (nearly) identical platforms.
- work towards demonstrating Raman-based aNSOM and improving NS $\mu$ M performance.

## Research Team:

**S.J. Stranick, C.A. Michaels and S.W. Robey:**

*NS<sub>μ</sub>M and Raman/IR NSOM.*

**P.K. Schenck, D.L. Kaiser and B. Hockey:**

*BST library fabrication.*

**R.B. Marinenko and J.T. Armstrong:**

*Electron probe microanalysis.*